


<b>Search Notes</b> 	<b>Application/Control No.</b> 10587805	<b>Applicant(s)/Patent Under Reexamination</b> EIDE ET AL.
	<b>Examiner</b> Kiet T Nguyen	<b>Art Unit</b> 2881

SEARCHED			
Class	Subclass	Date	Examiner
702	2,6,9,22,23	9/10/09	KN
436	29,30,31	9/10/09	KN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST including Interference Searched	9/10/09	KN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
702	2	9/10/09	KN

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